

# IRF7314Q

HEXFET® Power MOSFET

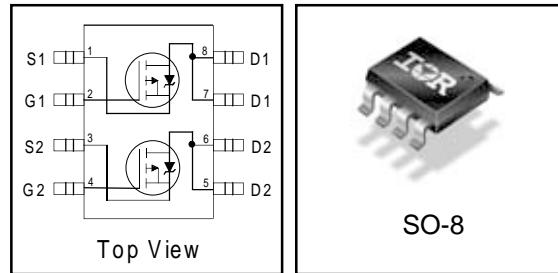
## Typical Applications

- Anti-lock Braking Systems (ABS)
- Electronic Fuel Injection
- Air bag

## Benefits

- Advanced Process Technology
- Dual P-Channel MOSFET
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Repetitive Avalanche Allowed up to Tjmax
- Automotive [Q101] Qualified

<b>V<sub>DSS</sub></b>	<b>R<sub>DS(on)</sub> max</b>	<b>I<sub>D</sub></b>
<b>-20V</b>	0.058@V <sub>GS</sub> = -4.5V	-5.2A
	0.098@V <sub>GS</sub> = -2.7V	-4.42A



## Description

Specifically designed for Automotive applications, these HEXFET® Power MOSFET's in a Dual SO-8 package utilize the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of these Automotive qualified HEXFET Power MOSFET's are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These benefits combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

The 175°C rating for the SO-8 package provides improved thermal performance with increased safe operating area and dual MOSFET die capability make it ideal in a variety of power applications. This dual, surface mount SO-8 can dramatically reduce board space and is also available in Tape & Reel.

## Absolute Maximum Ratings

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-Source Voltage	-20	V
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	-5.2	
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	-4.3	A
I <sub>DM</sub>	Pulsed Drain Current①	-43	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Maximum Power Dissipation③	2.4	W
P <sub>D</sub> @ T <sub>A</sub> = 70°C	Maximum Power Dissipation③	1.7	W
	Linear Derating Factor	16	mW/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 12	V
E <sub>AS</sub>	Single Pulse Avalanche Energy②	610	mJ
I <sub>AR</sub>	Avalanche Current①	-5.2	A
E <sub>AR</sub>	Repetitive Avalanche Energy	See Fig.14, 15, 16	mJ
T <sub>J</sub> , T <sub>STG</sub>	Junction and Storage Temperature Range	-55 to + 175	°C

## Thermal Resistance

	Parameter	Max.	Units
R <sub>θJA</sub>	Maximum Junction-to-Ambient ③	62.5	°C/W

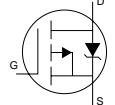
# IRF7314Q

International  
Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-20	—	—	V	$V_{\text{GS}} = 0\text{V}$ , $I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.009	—	$\text{V}^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = -1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	0.049	0.058	$\Omega$	$V_{\text{GS}} = -4.5\text{V}$ , $I_D = -5.2\text{A}$ ②
		—	0.082	0.098		$V_{\text{GS}} = -2.7\text{V}$ , $I_D = -4.42\text{A}$ ②
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	-0.7	—	—	V	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = -250\mu\text{A}$
$g_{\text{fs}}$	Forward Transconductance	6.8	—	—	S	$V_{\text{DS}} = 10\text{V}$ , $I_D = -5.2\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	-1.0	$\mu\text{A}$	$V_{\text{DS}} = -16\text{V}$ , $V_{\text{GS}} = 0\text{V}$
		—	—	-25		$V_{\text{DS}} = -16\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $T_J = 150^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{\text{GS}} = -12\text{V}$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{\text{GS}} = 12\text{V}$
$Q_g$	Total Gate Charge	—	19	29	nC	$I_D = -5.2\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	2.1	3.2		$V_{\text{DS}} = -16\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	9.3	14		$V_{\text{GS}} = -4.5\text{V}$
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	18	—	ns	$V_{\text{DD}} = -10\text{V}$
$t_r$	Rise Time	—	26	—		$I_D = -1.0\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	41	—		$R_G = 6.0\Omega$
$t_f$	Fall Time	—	38	—		$V_{\text{GS}} = -4.5\text{V}$ ②
$C_{\text{iss}}$	Input Capacitance	—	913	—	pF	$V_{\text{GS}} = 0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	512	—		$V_{\text{DS}} = -15\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	260	—		$f = 1.0\text{MHz}$

## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	-3.0	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	-43		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	-1.0	V	$T_J = 25^\circ\text{C}$ , $I_S = -3.0\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ②
$t_{rr}$	Reverse Recovery Time	—	44	66	ns	$T_J = 25^\circ\text{C}$ , $I_F = -3.0\text{A}$
$Q_{rr}$	Reverse Recovery Charge	—	54	81	nC	$dI/dt = -100\text{A}/\mu\text{s}$ ②

### Notes:

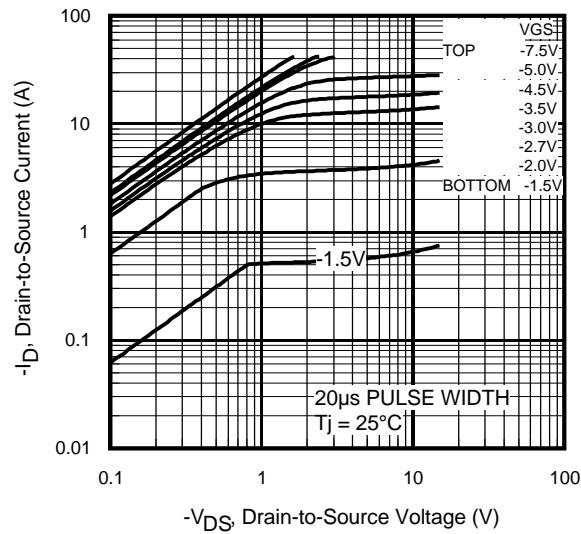
① Repetitive rating; pulse width limited by max. junction temperature.

③ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .

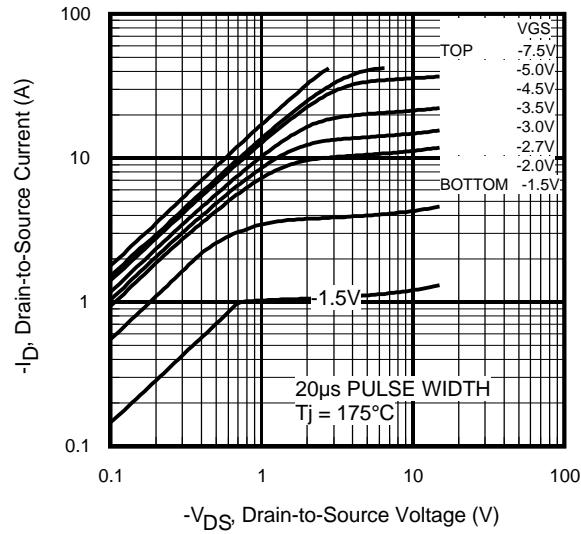
② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 45\text{mH}$

④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

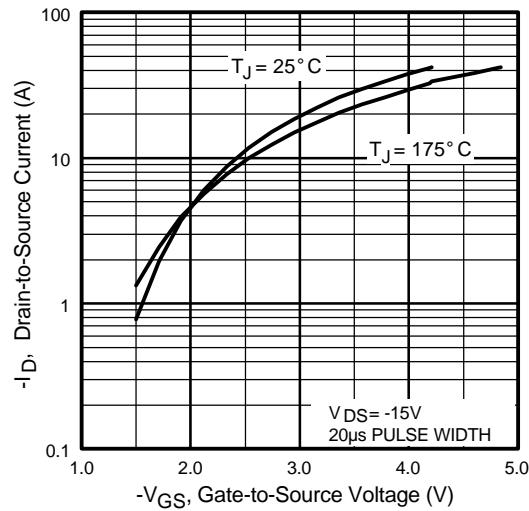
$R_G = 25\Omega$ ,  $I_{AS} = -5.2\text{A}$ .



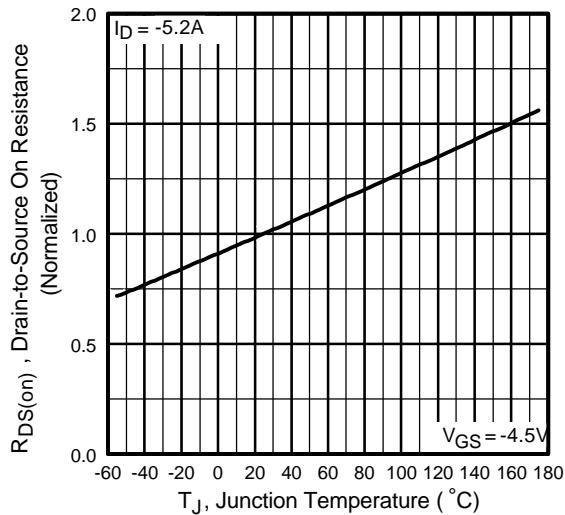
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



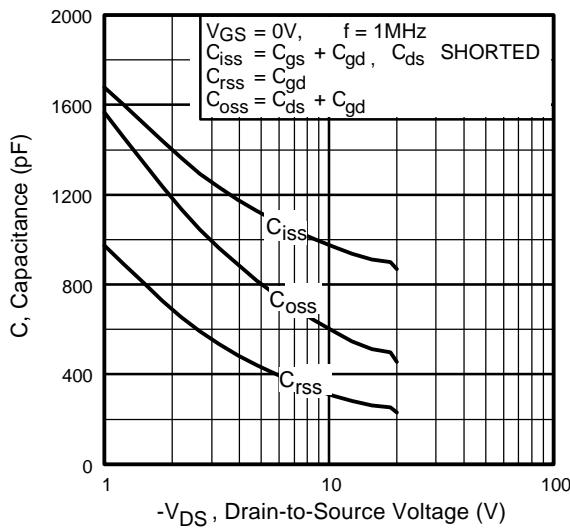
**Fig 3.** Typical Transfer Characteristics



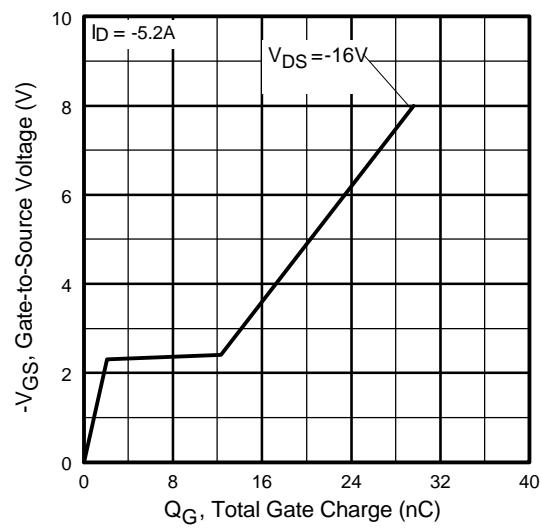
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

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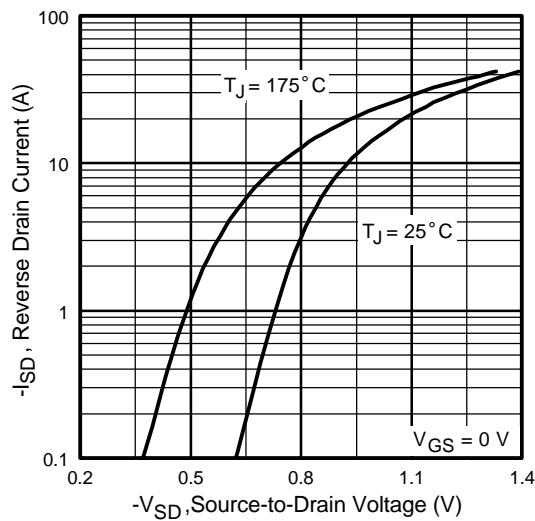
International  
**IR** Rectifier



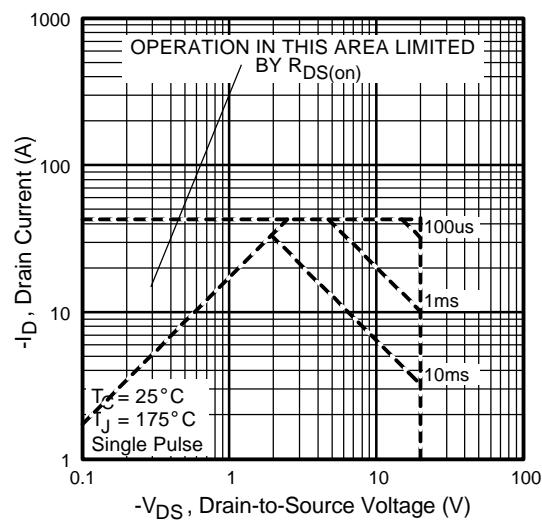
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



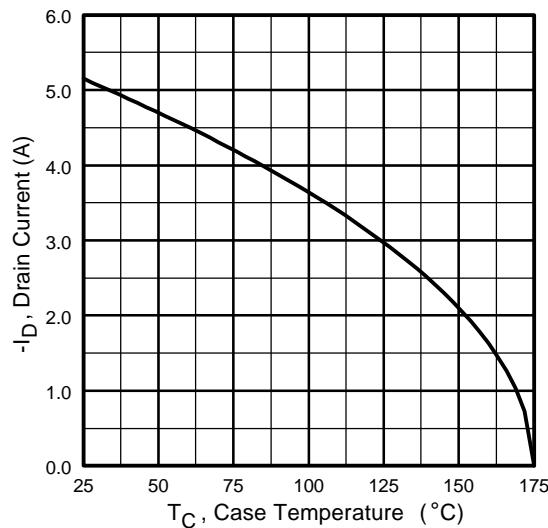
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



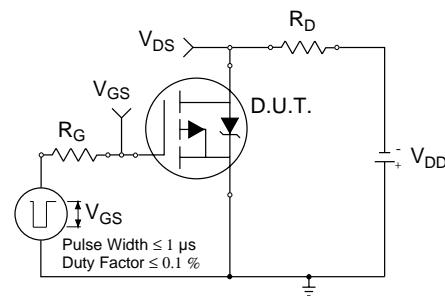
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



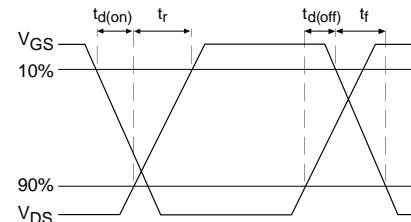
**Fig 8.** Maximum Safe Operating Area



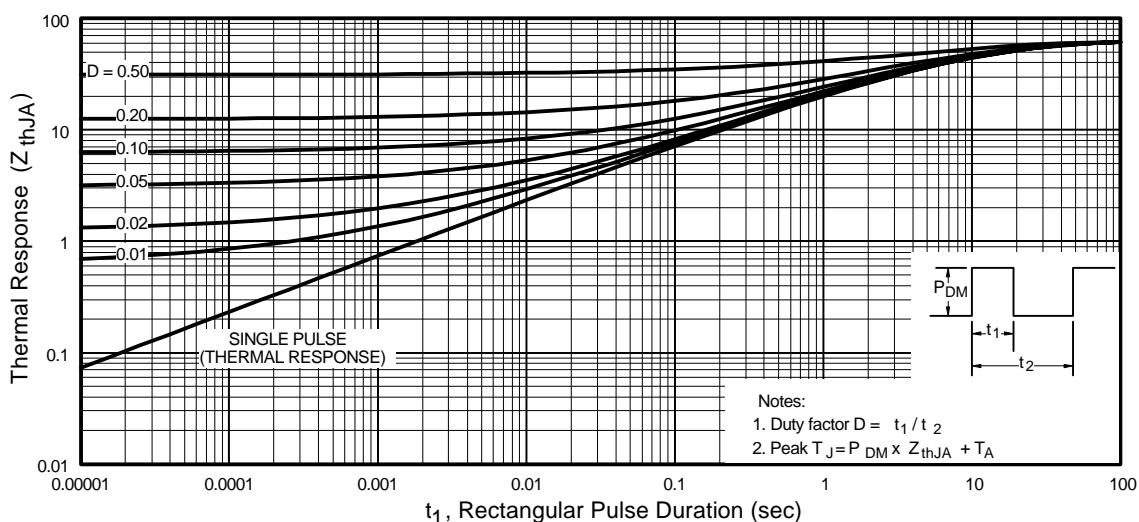
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



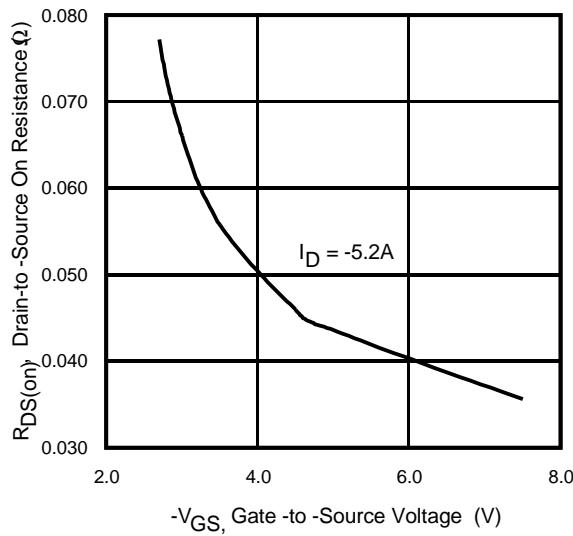
**Fig 10b.** Switching Time Waveforms



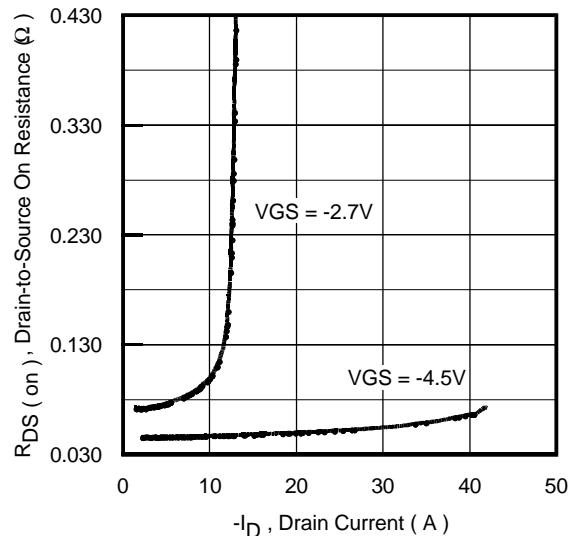
**Fig 10.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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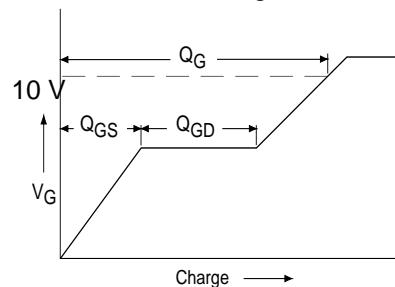
International  
**IR** Rectifier



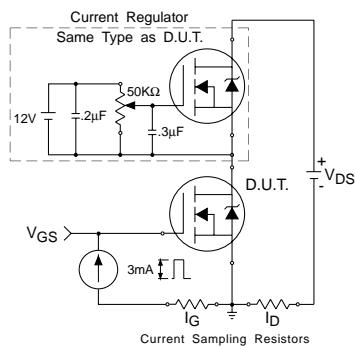
**Fig 11.** Typical On-Resistance Vs.  
Gate Voltage



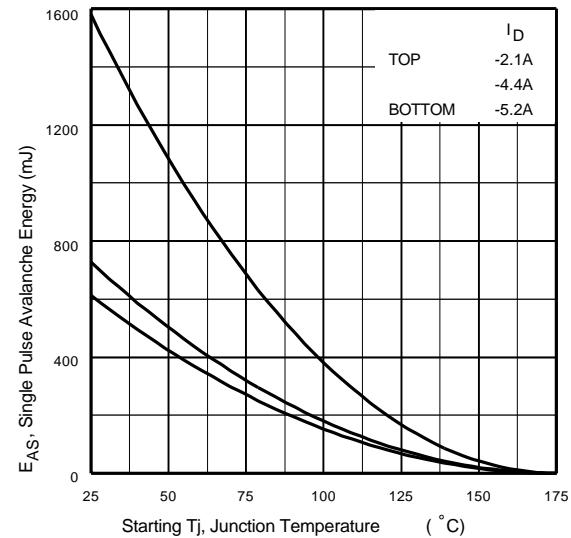
**Fig 12.** Typical On-Resistance Vs.  
Drain Current



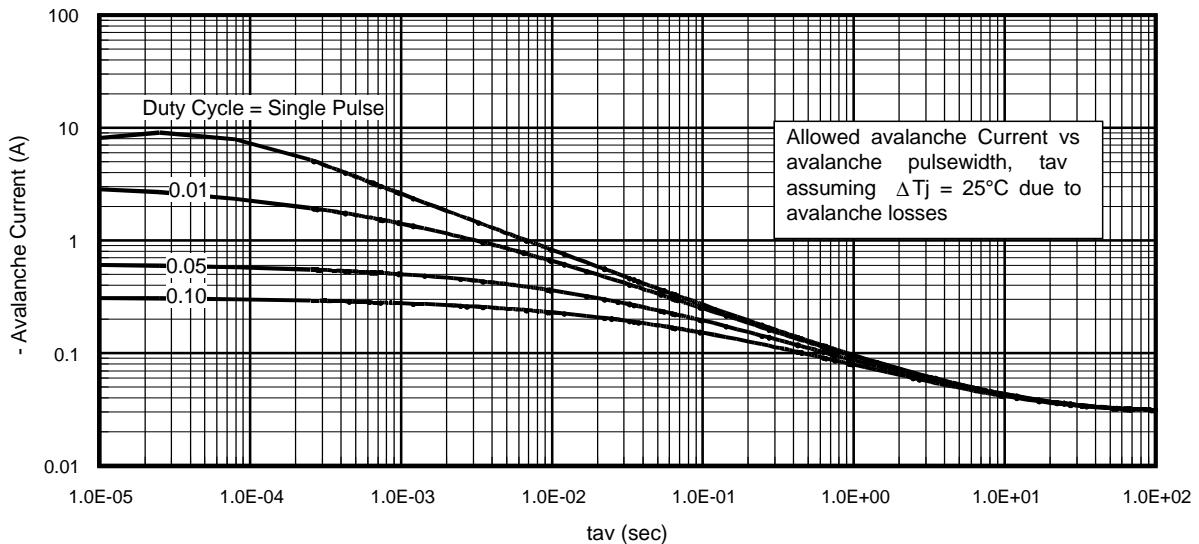
**Fig 13a.** Basic Gate Charge Waveform



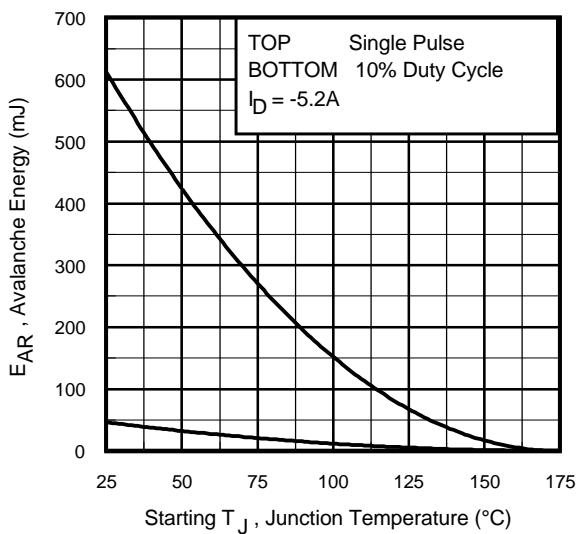
**Fig 13b.** Gate Charge Test Circuit



**Fig 14.** Maximum Avalanche Energy  
Vs. Drain Current



**Fig 15.** Typical Avalanche Current Vs.Pulsewidth



**Fig 16.** Maximum Avalanche Energy Vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 15, 16:  
 (For further info, see AN-1005 at [www.irf.com](http://www.irf.com))**

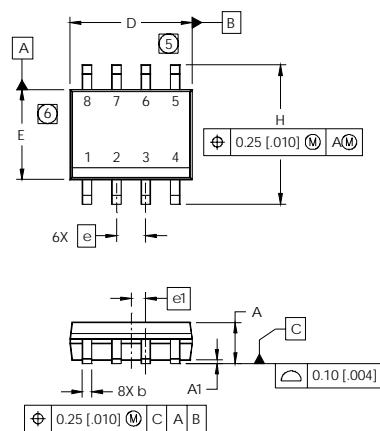
1. Avalanche failures assumption:  
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
  2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
  3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
  4.  $P_D(\text{ave})$  = Average power dissipation per single avalanche pulse.
  5.  $BV$  = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
  6.  $I_{av}$  = Allowable avalanche current.
  7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as  $25^\circ\text{C}$  in Figure 15, 16).
- $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} / f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$P_D(\text{ave}) = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

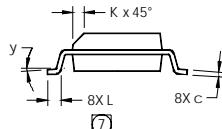
$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_D(\text{ave}) \cdot t_{av}$$

## SO-8 Package Details

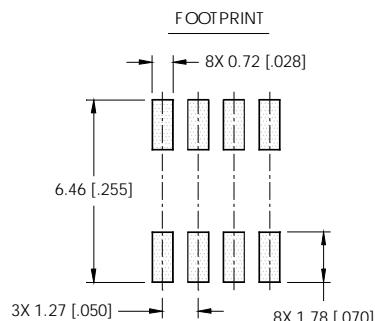


DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050	BASIC	1.27	BASIC
e1	.025	BASIC	0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°



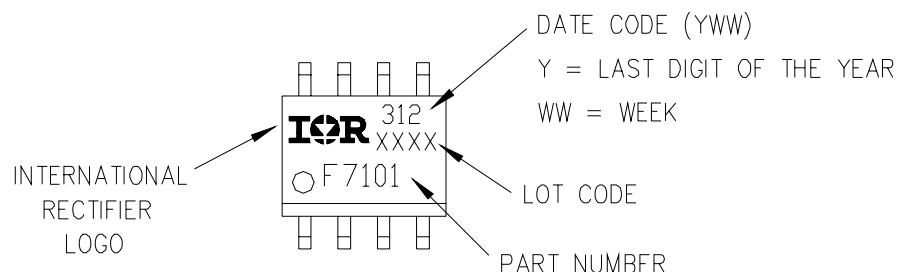
### NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- 5) DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS.  
MOLD PROTRUSIONS NOT TO EXCEED 0.15 [.006].
- 6) DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS.  
MOLD PROTRUSIONS NOT TO EXCEED 0.25 [.010].
- 7) DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO  
A SUBSTRATE.



## Part Marking

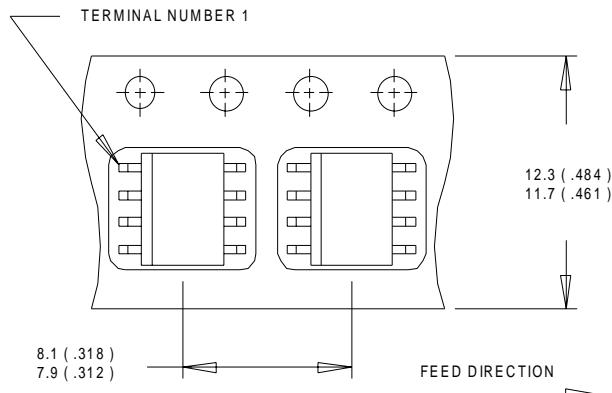
EXAMPLE: THIS IS AN IRF7101



International  
**IR** Rectifier

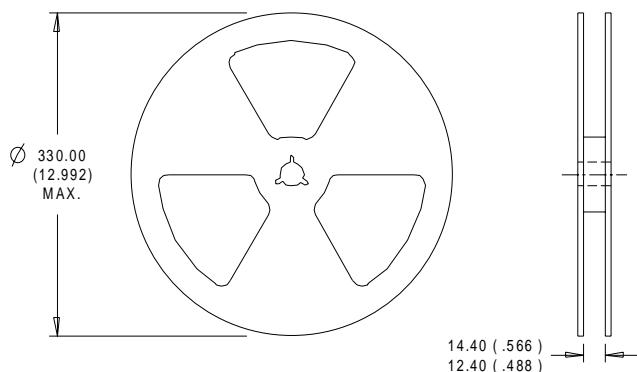
**IRF7314Q**

### Tape and Reel



NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Automotive [Q101] market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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TAC Fax: (310) 252-7903

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